Notice of References Cited

Application/Control No. 10/705,729	Applicant(s)/Patent Under Reexamination HIATT ET AL.	
Examiner	Art Unit	
Sharidan Carrillo	1746	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,805,971	09-1998	Akedo, Jun	419/6
*	В	US-2002/0090410	07-2002	Tochimoto et al.	425/215
*	С	US-2004/0084814	05-2004	Boyd et al.	264/497
*	D	US-2003/0067098	04-2003	Newell et al.	264/442
*	Ε	US-2004/0012112	01-2004	Davidson et al.	264/109
	F	US-			
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	Н	US-			
	_	US-			
	7	US-			
	K	US-			·
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	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2002-205339	07-2002	Japan	Tochimoto et al.	
	0				***************************************	
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	s					
	Т			*	·	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	>			
	8			
	x			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.